











LP5922

# LP5922 2-A Low-Noise, Adjustable LDO With Low Input- and Output-Voltage Capability

#### Features

Wide Input Voltage Range: 1.3 V to 6 V

Low V<sub>IN</sub> Voltage Without Extra Bias Voltage

Adjustable Output Voltage: 0.5 V to 5 V

Low Dropout: 200 mV at 2-A Load

Low Output Voltage Noise: 25 μV<sub>RMS</sub>

Output Current: 2 A

-40°C to +125°C Operating Junction Temperature

Programmable Soft Start Limits Inrush Current

3-mm × 3-mm × 0.75-mm 10-Pin WSON Package

Thermal-Overload and Short-Circuit Protection

Output Voltage Tolerance: ±1.5%

Shutdown Supply Current: 0.1 µA

PSRR: 70 dB at 1 kHz

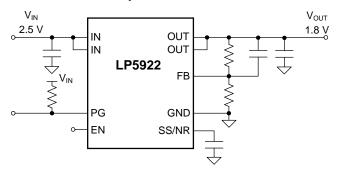
**Power Good Output** 

Create a Custom Design Using the LP5922 With the WEBENCH® Power Designer

# Applications

- **Space-Constrained Applications**
- Noise- and Ripple-Sensitive High Current Analog or RF Systems
- **Target Sectors** 
  - Medical, Test and Measurement Equipment
  - Portable and Consumer electronics
  - Telecom and Networking Cards
  - Wireless Infrastructure
  - **Industrial Applications**
- Typical Systems
  - Radio Transceivers, Power Amplifiers, PLL/Synthesizer, Clocking, VCO, GPRS, 3G Modules, FPGAs, DSP, GPUs, and others

#### Simplified Schematic



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# 3 Description

The LP5922 is 2-A low dropout (LDO) linear regulator with 200-mV typical dropout voltage at maximum current levels. The LP5922 device can operate from a voltage rail down to 1.3 V without additional bias supply. System efficiency is maximized and power dissipation minimized by the low dropout and low V<sub>IN</sub> capability. The device also features low quiescent current and very low shutdown current.

SNVSAG0A - NOVEMBER 2016-REVISED FEBRUARY 2017

The LP5922 device was designed to have high PSRR and low output noise to support sensitive analog applications without additional filtering. The output noise can be reduced even further by implementing a small capacitor on the SS/NR pin.

The output voltage is adjustable from 0.5 V to 5 V by an external resistor divider. Enable pin, adjustable soft start and optional Power Good features help with system power sequencing. Inrush current is controlled with the soft start and the device has short circuit and thermal protections.

# Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LP5922	WSON (10)	3.00 mm × 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

# **PSRR** -20 -40 -60 -80 $I_{OUT} = 2 A$ 10.20 10000 100000 1000000 Frequency (Hz)



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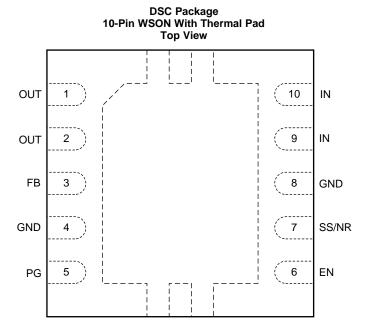
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# 4 Revision History

Changes from Original (November 2016) to Revision A	Page
Added links to WEBENCH	1
• Changed load transients test conditions from "V <sub>OUT</sub> = 3.3 V" to "V <sub>OUT</sub> = 2.8 V" and "t <sub>RISE</sub> = t <sub>FALL</sub> = 1 V/µs" to "t <sub>RISE</sub> = t <sub>FALL</sub> = 1 A/µs"	6
• Changed "t <sub>fall</sub> = 1 V/µs" to "t <sub>fall</sub> = 1 A/µs" in legend to Figure 9	8
<ul> <li>Changed scope shot in Figure 10 (was duplicate of Fig 9) and changed condition from "t<sub>fall</sub> = 1 V/μs" to "t<sub>fall</sub> = 1</li> <li>Α/μs"</li> </ul>	8
• Changed t <sub>fall</sub> = 1 V/μs" to "t <sub>RISE</sub> =t <sub>FALL</sub> = 5 μs" in Figure 11 conditions	8
Added Custom Design With WEBENCH Tools subsection	14



# 5 Pin Configuration and Functions



**Pin Functions** 

PIN		1/0	DESCRIPTION	
NUMBER	NAME	I/O	DESCRIPTION	
1	OUT	0	Regulated output voltage, connect directly to pin 2	
2	OUT	0	Regulated output voltage, connect directly to pin 1	
3	FB	I	Voltage feedback input to the internal error amplifier	
4	GND	Ground	Ground; connect to device pin 8.	
5	PG	0	Power Good to indicate the status of output voltage. Requires an external pullup resistor. When PG pin voltage is high the output voltage is considered good.	
6	EN	I	Enable	
7	SS/NR	I/O	Soft-start and noise reduction pin	
8	GND	Ground	Ground —connect to device pin 4.	
9	IN	I	Supply voltage input — connect directly to pin 10.	
10	IN	I	Supply voltage input —connect directly to pin 9.	
Exposed pad	Thermal Pad	_	The exposed thermal pad on the bottom of the package must be connected to a copper area under the package on the PCB. Connect to ground potential. Do not connect to any potential other than the same ground potential seen at device pins 4 and 8 (GND). See <i>Power Dissipation</i> for more information.	



# **Specifications**

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)(2)

	MIN	MAX	UNIT
IN pin voltage, V <sub>IN</sub>	-0.3	7	V
OUT pin voltage, V <sub>OUT</sub>		See <sup>(3)</sup>	
EN pin voltage, V <sub>EN</sub>	-0.3	7	V
PG pin voltage, V <sub>PG</sub>	-0.3	7	V
SS/NR pin voltage, V <sub>SS/NR</sub>	-0.3	3.6	V
FB pin voltage, V <sub>FB</sub>	-0.3	3.6	V
Junction temperature, T <sub>J</sub>		150	°C
Continuous power dissipation (4)	Internal	lly limited	
Storage temperature, T <sub>stg</sub>	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- All voltages are with respect to the potential at the GND pin.
- Absolute maximum  $V_{OUT}$  is the lesser of  $V_{IN}$  + 0.3 V, or 7 V. Internal thermal shutdown circuitry protects the device from permanent damage.

## 6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	
V <sub>(ESD)</sub>	discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±1000	V

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process

# 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

1 0 1	,			
	MIN	NOM MA	X	UNIT
Input voltage, V <sub>IN</sub>	1.3		6	V
Output voltage, V <sub>OUT</sub>	0.5		5	V
FB voltage, V <sub>FB</sub>		0.5		V
EN input voltage, V <sub>EN</sub>	0	V	'IN	V
Recommended load current, I <sub>L</sub>	0		2	Α
Operating junction temperature, T <sub>J-MAX-OP</sub>	-40	1:	25	°C

#### 6.4 Thermal Information

		LP5922	
	THERMAL METRIC <sup>(1)</sup>	DSC (WSON)	UNIT
		10 PINS	
$R_{\theta JA}^{(2)}$	Junction-to-ambient thermal resistance, High K	49.5 <sup>(3)</sup>	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	38.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	24.0	°C/W
ΨJΤ	Junction-to-top characterization parameter	0.5	°C/W
ΨЈВ	Junction-to-board characterization parameter	24.1	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	6.0	°C/W

For more information about traditional and new thermal metrics, see Semiconductor and IC Package Thermal Metrics.

Thermal resistance value R<sub>0JA</sub> is based on the EIA/JEDEC High-K printed circuit board defined by JESD51-7 - High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages.

The PCB for the WSON/DSC package R<sub>0,IA</sub> includes four (4) thermal vias, in a 2 x 2 array, under the exposed thermal pad per EIA/JEDEC JESD51-5.

JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 6.5 Electrical Characteristics

 $V_{IN} = V_{OUT(NOM)} + 0.5 \text{ V or } 1.3 \text{ V, whichever is greater; } V_{EN} = 1.2 \text{ V, } C_{IN} = 22 \text{ }\mu\text{F, } C_{OUT} = 22 \text{ }\mu\text{F, OUT connected to } 50 \text{ }\Omega \text{ to GND, } V_{FB} = 0.5 \text{ V, } C_{SS/NR} = 0.12 \text{ }\mu\text{F, } C_{FF} = 0.01 \text{ }\mu\text{F, and PG pin pulled up to } V_{IN} \text{ by } 100\text{-}k\Omega \text{ resistor (unless otherwise } 1.00 \text{ })$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
SUPPLY	VOLTAGE						
V <sub>IN</sub>	Input voltage range		1.3		6	V	
UVLO	Undervoltage lock-out threshold	V <sub>IN</sub> Rising (↑) until output is ON		1.2	1.25	V	
ΔUVLO	UVLO hysteresis	V <sub>IN</sub> Falling (↓) from UVLO threshold until output is OFF		160		mV	
OUTPUT	VOLTAGE AND REGULATI	ON			'		
V <sub>OUT</sub>	Output voltage range		0.5		5	V	
	Line regulation	I <sub>OUT</sub> = 5 mA, 1.3 V ≤ V <sub>IN</sub> ≤ 6 V		0.02		%/V	
$\Delta V_{OUT}$	Load regulation	5 mA ≤ I <sub>OUT</sub> ≤ 2 A		0.1		%/A	
		V <sub>IN</sub> = 1.4 V, I <sub>OUT</sub> = 2 A		220	400		
$V_{DO}$	Dropout voltage (4)	V <sub>IN</sub> = 2.5 V, I <sub>OUT</sub> = 2 A		100	180	mV	
		V <sub>IN</sub> = 5.3 V, I <sub>OUT</sub> = 2 A		90	160		
FB							
V <sub>FB</sub>	FB voltage	I <sub>OUT</sub> = 5 mA to 2 A	492.5	500	507.5	mV	
I <sub>FB</sub>	FB pin input current	V <sub>FB</sub> = 0.5 V	-100		100	nA	
CURREN	T LEVELS						
IL	Maximum load current	V <sub>IN</sub> ≥ 1.3 V	2			Α	
I <sub>SC</sub>	Short-circuit current limit (5)		2.2	3	3.8	Α	
	Ground-current minimum load (6)	V <sub>IN</sub> = 6 V, I <sub>OUT</sub> = 0 mA		0.7		1	
I <sub>GND</sub>	Ground-current maximum load (6)	V <sub>IN</sub> = 1.3 V, I <sub>OUT</sub> = 2 A		1	4	mA	
I <sub>GND(SD)</sub>	Shutdown current <sup>(7)</sup>	V <sub>IN</sub> = 6 V, V <sub>EN</sub> = 0 V, V <sub>PG</sub> = 0 V		0.1	15	μA	
V <sub>IN</sub> to V <sub>O</sub>	UT RIPPLE REJECTION (8)						
		$V_{IN} \ge 1.4 \text{ V}, f = 1 \text{ kHz}, I_{OUT} = 2 \text{ A}$		70			
DODD	Power-supply rejection	$V_{IN} \ge 1.4 \text{ V}, f = 10 \text{ kHz}, I_{OUT} = 2 \text{ A}$		55			
PSRR	ratio	V <sub>IN</sub> ≥ 1.4 V, f = 100 kHz, I <sub>OUT</sub> = 2 A		40		dB	
		V <sub>IN</sub> ≥ 1.4 V, f = 1 MHz, I <sub>OUT</sub> = 2 A		30			
OUTPUT	NOISE VOLTAGE				,		
e <sub>N</sub>	Noise voltage <sup>(8)</sup>	V <sub>IN</sub> = 2.5 V, V <sub>OUT</sub> = 1.8 V BW = 10 Hz to 100 kHz		25		$\mu V_{RMS}$	

- All voltages are with respect to the GND pin.
- Minimum and maximum limits are design targeted limits over the junction temperature (T<sub>J</sub>) range of -40°C to +125°C, unless otherwise stated. Typical values represent the most likely parametric norm at  $T_J = 25$ °C, and are provided for reference purposes only.
- CIN, COLIT: Low-ESR surface-mount-ceramic capacitors (MLCCs) used in setting electrical characteristics.
- Dropout voltage is the voltage difference between the input and the output at which the FB voltage drops to 97% of its nominal value.
- Short-circuit current (I<sub>SC</sub>) is equivalent to current limit. To minimize thermal effects during testing, I<sub>SC</sub> is measured with V<sub>OUT</sub> pulled to 100 mV below its nominal voltage.
- Ground current is defined here as the total current flowing to ground as a result of all voltages applied to the device 
  $$\begin{split} &I_{GND} = (\ (I_{IN} - I_{OUT}) + I_{EN} + I_{LKG(PG)}) \\ &Ground\ current\ in\ shutdown\ mode,\ I_{GND(SD),}\ does\ NOT\ include\ current\ from\ PG\ pin. \end{split}$$
- This specification is verified by design.

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# **Electrical Characteristics (continued)**

 $V_{IN} = V_{OUT(NOM)} + 0.5 \text{ V or } 1.3 \text{ V, whichever is greater; } V_{EN} = 1.2 \text{ V, } C_{IN} = 22 \text{ }\mu\text{F, } C_{OUT} = 22 \text{ }\mu\text{F, } OUT \text{ connected to } 50 \text{ }\Omega \text{ to } GND, V_{FB} = 0.5 \text{ V, } C_{SS/NR} = 0.12 \text{ }\mu\text{F, } C_{FF} = 0.01 \text{ }\mu\text{F, } \text{ and PG pin pulled up to } V_{IN} \text{ by } 100\text{-k}\Omega \text{ resistor (unless otherwise noted).}$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
LOGIC IN	IPUT THRESHOLDS		-			
V <sub>IL(EN)</sub>	EN pin low threshold	V <sub>EN</sub> falling (↓) until output is OFF			0.35	V
V <sub>IH(EN)</sub>	EN pin high threshold	V <sub>EN</sub> rising (↑) until output is ON	1.2			V
I <sub>EN</sub>	Input current at EN pin (9)	V <sub>IN</sub> = 6 V, V <sub>EN</sub> = 6 V		3		μΑ
$PG_{HTH}$	PG high threshold (% of nominal V <sub>OUT</sub> )	V <sub>OUT</sub> rising (↑) until PG goes high		94%		
PG <sub>LTH</sub>	PG low threshold (% of nominal V <sub>OUT</sub> )	V <sub>OUT</sub> falling (↓) until PG goes low		90%		
V <sub>OL(PG)</sub>	PG pin low-level output voltage	V <sub>OUT</sub> < PG <sub>LTH</sub> , sink current = 1 mA			400	mV
I <sub>LKG(PG)</sub>	PG pin leakage current	V <sub>OUT</sub> > PG <sub>HTH</sub> , V <sub>PG</sub> = 6 V			1	μΑ
SOFT ST	ART				·	
I <sub>SS</sub>	SS/NR pin charging current			6.2		μΑ
THERMA	L SHUTDOWN					
T <sub>SD</sub>	Thermal shutdown temperature			165		°C
$\Delta T_{SD}$	Thermal shutdown hysteresis			15		°C
TRANSIT	TON CHARACTERISTICS		1		1	
A)/	Line transients	$\Delta V_{IN} = 0.5 \text{ V}, V_{OUT} = 2.8 \text{ V},$ $t_{RISE} = t_{FALL} = 5 \mu\text{s}$		3		mV
ΔV <sub>OUT</sub>	Load transients	$V_{OUT}$ = 2.8 V, $I_{OUT}$ = 10 mA to 2 A to 10 mA $t_{RISE}$ = $t_{FALL}$ = 1 A/ $\mu$ s		25		IIIV
R <sub>AD</sub>	Output discharge pull- down resistance	V <sub>EN</sub> = 0 V, V <sub>IN</sub> = 2.3 V		400		Ω

<sup>(9)</sup> There is a 2-M $\Omega$  resistor between EN and ground (pulldown) on the device.

# 6.6 Input and Output Capacitors

over operating free-air temperature range (unless otherwise noted)

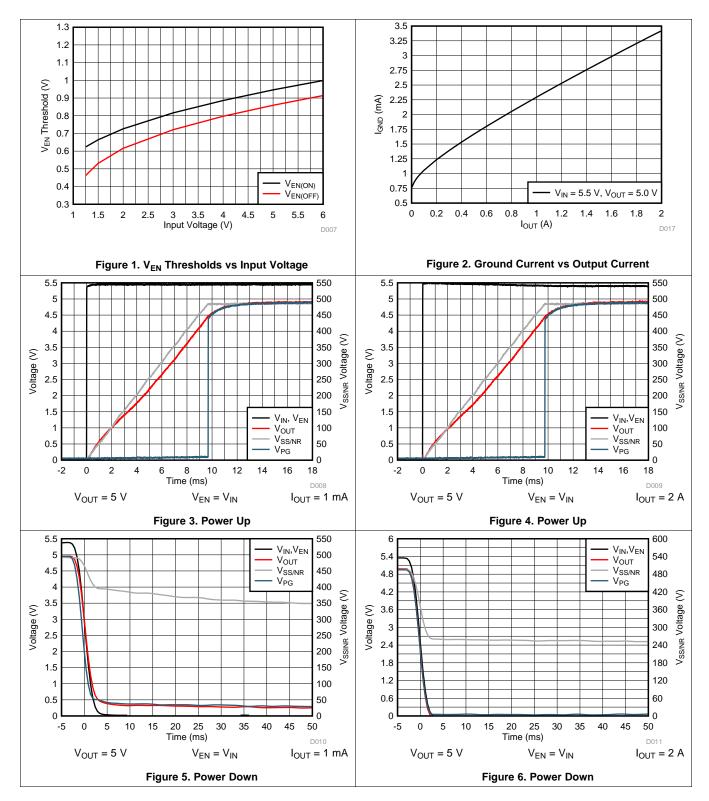
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
C <sub>IN</sub>	Input capacitance <sup>(1)</sup>			22		μF
0	Output conscitones	V <sub>OUT</sub> ≤ 0.8 V	34	47		
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> > 0.8 V	15	22		μF

(1) Typically input capacitance placed close to the device is in the same order as output capacitance. See also Input Capacitor, C<sub>IN</sub>.



# 6.7 Typical Characteristics

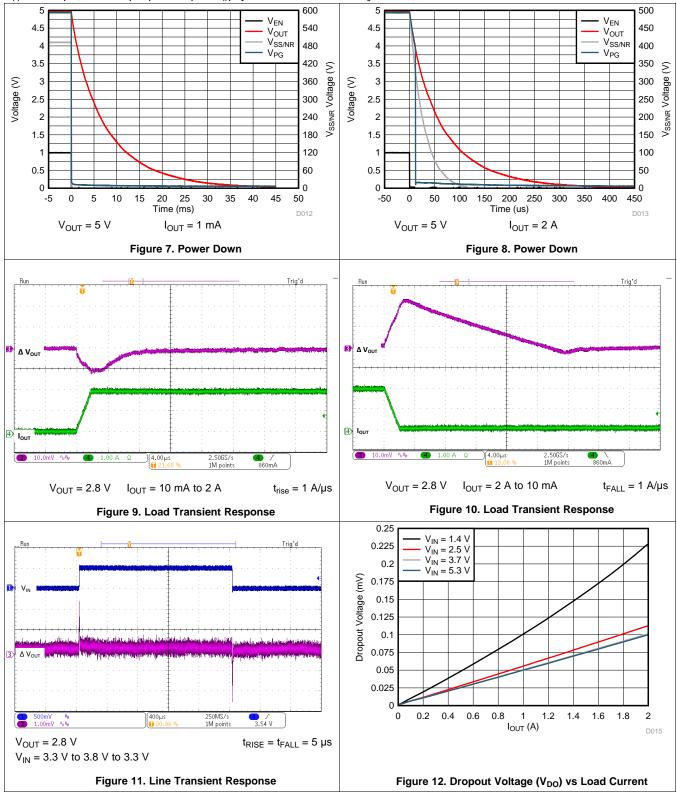
 $V_{\text{IN}} = V_{\text{OUT}} + 0.5 \text{ V}, V_{\text{EN}} = 1.2 \text{ V}, C_{\text{IN}} = 22 \text{ }\mu\text{F}, C_{\text{OUT}} = 22 \text{ }\mu\text{F}, \text{OUT connected to } 50 \text{ }\Omega \text{ to GND}, V_{\text{FB}} = 0.5 \text{ V}, C_{\text{SS/NR}} = 0.12 \text{ }\mu\text{F}, C_{\text{FF}} = 0.01 \text{ }\mu\text{F}, \text{ and PG pin pulled up to } V_{\text{IN}} \text{ by } 100\text{-k}\Omega \text{ resistor and } T_{\text{J}} = 25^{\circ}\text{C}, \text{ unless otherwise stated.}$ 



# TEXAS INSTRUMENTS

# **Typical Characteristics (continued)**

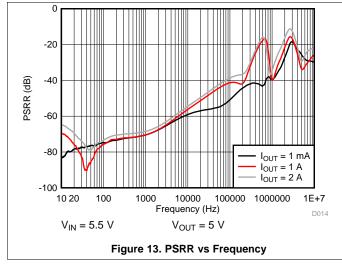
 $V_{IN}=V_{OUT}+0.5~V,~V_{EN}=1.2~V,~C_{IN}=22~\mu\text{F},~C_{OUT}=22~\mu\text{F},~OUT~connected~to~50~\Omega~to~GND,~V_{FB}=0.5~V,~C_{SS/NR}=0.12~\mu\text{F},~C_{FF}=0.01~\mu\text{F},~and~PG~pin~pulled~up~to~V_{IN}~by~100-k\Omega~resistor~and~T_{J}=25^{\circ}\text{C},~unless~otherwise~stated.}$ 





# **Typical Characteristics (continued)**

 $V_{\text{IN}} = V_{\text{OUT}} + 0.5 \text{ V}, V_{\text{EN}} = 1.2 \text{ V}, C_{\text{IN}} = 22 \text{ }\mu\text{F}, C_{\text{OUT}} = 22 \text{ }\mu\text{F}, \text{OUT connected to } 50 \text{ }\Omega\text{ to GND}, V_{\text{FB}} = 0.5 \text{ V}, C_{\text{SS/NR}} = 0.12 \text{ }\mu\text{F}, C_{\text{FF}} = 0.01 \text{ }\mu\text{F}, \text{ and PG pin pulled up to } V_{\text{IN}} \text{ by } 100\text{-k}\Omega\text{ resistor and } T_{\text{J}} = 25^{\circ}\text{C}, \text{ unless otherwise stated.}$ 



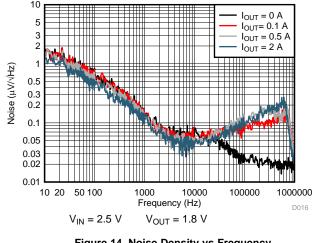


Figure 14. Noise Density vs Frequency



# 7 Detailed Description

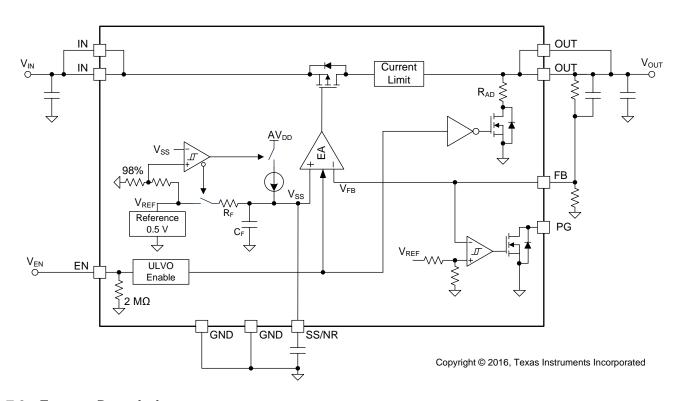
#### 7.1 Overview

The LP5922 is a low-noise, high PSRR, low-dropout regulator capable of sourcing a 2-A load. The LP5922 can operate down to 1.3-V input voltage and 0.5-V output voltage. This combination of low noise, high PSRR, and low output voltage makes the device an ideal low dropout (LDO) regulator to power a multitude of loads from noise-sensitive communication components to battery-powered system.

The LP5922 block diagram contains several features, including:

- Low-noise, 0.5-V reference
- Internal protection circuit, such as current limit and thermal shutdown
- Programmable soft-start circuit
- Power Good output

# 7.2 Functional Block Diagram



#### 7.3 Feature Description

#### 7.3.1 Output Voltage

The LP5922 output voltage can be set to any value from 0.5 V to 5 V using two external resistors shown as  $R_{UPPER}$  and  $R_{LOWER}$  in Figure 15. The value for the  $R_{LOWER}$  should be less than or equal to 100 k $\Omega$  for good loop compensation.  $R_{UPPER}$  can be selected for a given  $V_{OUT}$  using Equation 1:

$$R_{UPPER} = \frac{(V_{OUT} - V_{FB}) \times R_{LOWER}}{V_{FB}}$$

where

•  $V_{FB} = 0.5 \text{ V}$  (1)



## Feature Description (continued)

#### **7.3.2** Enable

The LP5922 EN pin is internally held low by a 2-MΩ resistor to GND. The EN pin voltage must be higher than the VIH threshold to ensure that the device is fully enabled under all operating conditions. The EN pin voltage must be lower than the VIL threshold to ensure that the device is fully disabled and the automatic output discharge is activated.

#### 7.3.3 Output Automatic Discharge

The LP5922 output employs an internal 400- $\Omega$  (typical) pulldown resistance to discharge the output capacitor when the EN pin is low, and the device is disabled.

## 7.3.4 Programmable Soft Start and Noise Reduction

The output voltage of LP5922 ramps up linearly in a constant slew rate until reaching the target regulating voltage after a stable V<sub>IN</sub> (greater than V<sub>OUT</sub> + V<sub>DO</sub>) is supplied and EN pin is pulled high. The slew rate of V<sub>OUT</sub> ramping is programmable by an external capacitor on the SS/NR pin; therefore, the duration for soft-start period is programmable as well. Once the LP5922 is enabled, the SS/NR pin sources a constant 6-µA current to charge the external C<sub>SS/NR</sub> capacitor until the voltage at the SS/NR pin reaches 98% of the internal reference voltage (V<sub>REF</sub>) of 500 mV typical. The final 2% of C<sub>SS/NR</sub> charge is determined by a RC time constant. During the softstart period, the current flowing into the IN pin primarily consists of the sum of the load current at the LDO output and the charging current into the output capacitor. The soft-start period can be calculated by Equation 2:

$$t_{SS} = \frac{C_{SS/NR} \times V_{FB}}{I_{SS}}$$

where

- $V_{FB} = 0.5 \text{ V}$  this is the voltage that  $C_{SS/NR}$  charges to;
- · C<sub>SS/NR</sub> is the value of the capacitor connected between the SS/NR pin and ground; and
- $I_{SS} = 6.2 \,\mu\text{A}$  is the typical charging current to the SS/NR pin during start-up period.

(2)

The recommended value for C<sub>SS/NR</sub> is 100 nF or larger. Equation 2 is most accurate for these values. The C<sub>SS/NR</sub> capacitor is also the filter capacitor for internal reference for noise reduction purpose. An integrated resistor and the C<sub>SS/NR</sub> capacitor structure a RC low-pass filter to remove the noise on the internal reference voltage.

#### 7.3.5 Internal Current Limit

The internal current limit circuit is used to protect the LDO against high-load current faults or shorting events. The LDO is not designed to operate in a steady-state current limit. During a current-limit event, the LDO sources constant current. Therefore, the output voltage falls when load impedance decreases. Note also that if a current limit occurs and the resulting output voltage is low, excessive power may be dissipated across the LDO, resulting in a thermal shutdown of the output.

#### 7.3.6 Thermal Overload Protection

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Thermal shutdown disables the output when the junction temperature rises to T<sub>SD</sub> level, which allows the device to cool. When the junction temperature cools by  $\Delta T_{SD}$ , the output circuitry enables. Based on power dissipation, thermal resistance, and ambient temperature, the thermal protection circuit may cycle on and off. This thermal cycling limits the dissipation of the regulator and protects it from damage as a result of overheating.

The internal protection circuitry of the LP5922 is designed to protect against thermal overload conditions. The circuitry is not intended to replace proper heat sinking. Continuously running the LP5922 into thermal shutdown degrades device reliability.



## **Feature Description (continued)**

#### 7.3.7 Power Good Output

The LP5922 has a Power-Good function that works by toggling the state of the PG output pin. When the output voltage falls below the PG threshold voltage (PG<sub>LTH</sub>), the PG pin open-drain output engages (low impedance to GND). When the output voltage rises above the PG threshold voltage (PG<sub>HTH</sub>), the PG pin becomes high-impedance. By connecting a pullup resistor to an external supply, any downstream device can receive PG as a logic signal. User must make sure that the external pullup supply voltage results in a valid logic signal for the receiving device or devices; use a pullup resistor from 10 k $\Omega$  to 100 k $\Omega$  for best results.

In Power-Good function, the PG output pin pulled high immediatelly after output voltage rises above the PG threshold voltage.

#### 7.4 Device Functional Modes

## 7.4.1 Enable (EN)

The LP5922 enable (EN) pin is internally held low by a 2-M $\Omega$  resistor to GND. If the EN pin is open the output is OFF. The EN pin voltage must be higher than the V<sub>IH</sub> threshold to ensure that the device is fully enabled under all operating conditions. When the EN pin is pulled low, and the output is disabled, the output automatic discharge circuit is activated. Any charge on the OUT pin is discharged to GND through the internal pulldown resistance.

#### 7.4.2 Undervoltage Lockout (UVLO)

The LP5922 incorporates UVLO. The UVLO circuit monitors the input voltage and keeps the LP5922 disabled while a rising  $V_{IN}$  is less than 1.2 V (typical). The rising UVLO threshold is approximately 100 mV below the recommended minimum operating  $V_{IN}$  of 1.3 V.

# 7.4.3 Minimum Operating Input Voltage

The LP5922 internal circuit is not fully functional until  $V_{IN}$  is at least 1.3 V. The output voltage is not regulated until  $V_{IN}$  has reached at least the greater of 1.3 V or  $(V_{OLIT} + V_{DO})$ .



# 8 Applications and Implementation

#### NOTE

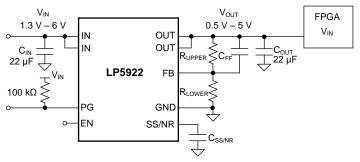
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

The LP5922 is designed to meet the requirements of RF and analog circuits, by providing low noise, high PSRR, low quiescent current, and low line or load transient response figures. The device offers excellent noise performance without the need for a noise bypass capacitor and is stable with input and output capacitors with a value of 22  $\mu$ F. The LP5922 delivers this performance in an industry-standard WSON package which, for this device, is specified with an operating junction temperature (T<sub>1</sub>) of  $-40^{\circ}$ C to  $+125^{\circ}$ C.

#### 8.2 Typical Application

Figure 15 shows the typical application circuit for the LP5922. Input and output capacitances may need to be increased above 22 µF minimum for some applications.



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Figure 15. LP5922 Typical Application

#### 8.2.1 Design Requirements

For typical LP5922 applications, use the parameters listed in Table 1.

**Table 1. Design Parameters** 

DESIGN PARAMETER	EXAMPLE VALUE		
Input voltage	2.25 V to 2.75 V		
Output voltage	1.8 V		
Output current	2000 mA		
Output capacitor range	22 μF to 47 μF		
Output capacitor ESR range	2 m $\Omega$ to 500 m $\Omega$		



#### 8.2.2 Detailed Design Procedure

#### 8.2.2.1 Custom Design With WEBENCH® Tools

Click here to create a custom design using the LP5922 device with the WEBENCH® Power Designer.

- 1. Start by entering the input voltage  $(V_{IN})$ , output voltage  $(V_{OUT})$ , and output current  $(I_{OUT})$  requirements.
- 2. Optimize the design for key parameters such as efficiency, footprint, and cost using the optimizer dial.
- 3. Compare the generated design with other possible solutions from Texas Instruments.

The WEBENCH Power Designer provides a customized schematic along with a list of materials with real-time pricing and component availability.

In most cases, these actions are available:

- Run electrical simulations to see important waveforms and circuit performance
- · Run thermal simulations to understand board thermal performance
- · Export customized schematic and layout into popular CAD formats
- Print PDF reports for the design, and share the design with colleagues

Get more information about WEBENCH tools at www.ti.com/WEBENCH.

#### 8.2.2.2 External Capacitors

The LP5922 is designed to be stable using low equivalent series resistance (ESR) ceramic capacitors at the input, output, and the noise-reduction pin (SS/NR). Multilayer ceramic capacitors have become the industry standard for these types of applications and are recommended, but must be used with good judgment. Ceramic capacitors that employ X7R-, X5R-, and COG-rated dielectric materials provide relatively good capacitive stability across temperature, whereas the use of Y5V-rated capacitors is discouraged because of large variations in capacitance. Additionally, the case size has a direct impact on the capacitance versus applied voltage derating.

Regardless of the ceramic capacitor type selected, the actual capacitance varies with the applied operating voltage and temperature. As a rule of thumb, derate ceramic capacitors by at least 50%. The input and output capacitors recommended herein account for a effective capacitance derating of approximately 50%, but at high applied voltage conditions the capacitance derating can be greater than 50% and must be taken into consideration. The minimum capacitance values declared in *Input and Output Capacitors* must be met across the entire expected operating voltage range and temperature range.

#### 8.2.2.3 Input Capacitor, C<sub>IN</sub>

An input capacitor is required for stability. A capacitor with a value of at least 22  $\mu$ F must be connected between the LP5922 IN pin and ground for stable operation over full load current range. It is acceptable to have more output capacitance than input, as long as the input is at least 22  $\mu$ F.

The input capacitor must be located as close as possible to, but at a distance not more than 1 cm from, the IN pin and returned to the device GND pin with a clean analog ground. This will minimize the trace inductance between the capacitor and the device. Any good quality ceramic or tantalum capacitor may be used at the input.

# 8.2.2.4 Output Capacitor, C<sub>OUT</sub>

The LP5922 is designed to work specifically with a low ESR ceramic (MLCC) output capacitor, typically 22  $\mu$ F. A ceramic capacitor (dielectric types X5R or X7R) in the 22- $\mu$ F to 100- $\mu$ F range, with an ESR not exceeding 500 m $\Omega$ , is suitable in the LP5922 application circuit having an output voltage greater than 0.8 V. For output voltages of 0.8 V or less, the output capacitance must be increased to typically 47  $\mu$ F. The output capacitor must be connected between the device OUT and GND pins. The output capacitor must meet the requirement for the minimum value of capacitance and have an ESR value that does not exceed 500 m $\Omega$  to ensure stability.

It is possible to use tantalum capacitors at the device output, but these are not as attractive for reasons of size, cost, and performance.



A combination of multiple output capacitors in parallel boosts the high-frequency PSRR. The combination of one 0805-sized, 47- $\mu$ F ceramic capacitor in parallel with two 0805-sized, 10- $\mu$ F ceramic capacitors with a sufficient voltage rating optimizes PSRR response in the frequency range of 400 kHz to 700 kHz (which is a typical range for dc-dc supply switching frequency). This 47- $\mu$ F || 10- $\mu$ F || 10- $\mu$ F combination also ensures that at high input voltage and high output voltage configurations, the minimum effective capacitance is met. Many 0805-sized, 47- $\mu$ F ceramic capacitors have a voltage derating of approximately 60% to 75% at 5 V, so the addition of the two 10- $\mu$ F capacitors ensures that the capacitance is at or above 22  $\mu$ F.

#### 8.2.2.5 Soft-Start and Noise-Reduction Capacitor, C<sub>SS/NR</sub>

Recommended value for  $C_{SS/NR}$  is 100 nF or larger. The soft-start period can be calculated by Equation 2. The  $C_{SS/NR}$  capacitor is also the filter capacitor for internal reference for noise reduction purpose.

#### 8.2.2.6 Feed-Forward Capacitor, CFF

Although a feed-forward capacitor ( $C_{FF}$ ) from the FB pin to the OUT pin is not required to achieve stability, a 10-nF external  $C_{FF}$  optimizes the transient, noise, and PSRR performance. A higher capacitance  $C_{FF}$  value can be used; however, the start-up time may be longer and the Power-Good signal may incorrectly indicate that the output voltage is settled. The maximum recommended value is 100 nF

To ensure proper PGx functionality, the time constant defined by CNR/SSx must be greater than or equal to the time constant from CFFx. For a detailed description, see the application report *Pros and Cons of Using a Feed-Forward Capacitor with a Low Dropout Regulator* (SBVA042).

#### 8.2.2.7 No-Load Stability

The LP5922 remains stable, and in regulation, with no external load.

#### 8.2.2.8 Power Dissipation

Knowing the device power dissipation and proper sizing of the thermal plane connected to the exposed thermal pad is critical to ensuring reliable operation. Device power dissipation depends on input voltage, and load conditions and can be calculated with Equation 3.

$$P_{D(MAX)} = (V_{IN(MAX)} - V_{OUT}) \times I_{OUT}$$
(3)

Power dissipation can be minimized, and greater efficiency can be achieved, by using the lowest available voltage drop option that is greater than the dropout voltage  $(V_{DO})$ . However, keep in mind that higher voltage drops result in better dynamic (that is, PSRR and transient) performance.

On the WSON (DSC) package, the primary conduction path for heat is through the exposed thermal pad into the PCB. To ensure the device does not overheat, connect the exposed thermal pad, through multiple thermal vias, to an internal ground plane with an appropriate amount of PCB copper area.

Power dissipation and junction temperature are most often related by the junction-to-ambient thermal resistance  $(R_{\theta JA})$  of the combined PCB and device package and the temperature of the ambient air  $(T_A)$ , according to Equation 4 or Equation 5:

$$T_{J(MAX)} = T_{A(MAX)} + (R_{\theta JA} \times P_{D(MAX)}) \tag{4}$$

$$P_{D} = \left(T_{J(MAX)} - T_{A(MAX)}\right) / R_{\theta JA} \tag{5}$$

If the  $V_{IN} - V_{OUT}$  voltage is known, the maximum allowable output current can be calculated with Equation 6

$$I_{OUT(MAX)} = (((125^{\circ}C - T_A) / R_{\theta JA}) / (V_{IN} - V_{OUT}))$$
(6)

Unfortunately, the  $R_{\theta JA}$  value is highly dependent on the heat-spreading capability of the particular PCB design, and therefore varies according to the PCB size, total copper area, copper weight, any thermal vias, and location of the planes. The  $R_{\theta JA}$  recorded in *Thermal Information* is determined by the specific EIA/JEDEC JESD51-7 standard for PCB and copper spreading area, and is to be used only as a relative measure of package thermal performance. For a well designed thermal layout,  $R_{\theta JA}$  is actually the sum of the package junction-to-case (bottom) thermal resistance ( $R_{\theta JC(bot)}$ ) plus the thermal resistance contribution by the PCB copper area acting as a heat sink.



#### 8.2.2.9 Estimating Junction Temperature

The JEDEC standard now recommends the use of psi  $(\Psi)$  thermal metrics to estimate the junction temperatures of the LDO when in-circuit on a typical PCB board application. These metrics are not strictly speaking thermal resistances, but rather offer practical and relative means of estimating junction temperatures. These psi metrics are determined to be significantly independent of the copper-spreading area. The key thermal metrics  $(\Psi_{JT})$  and  $(\Psi_{JB})$  are given in the *Thermal Information* table and are used in accordance with Equation 7 and Equation 8.

$$T_{J(MAX)} = T_{TOP} + (\Psi_{JT} \times P_{D(MAX)})$$

#### where

- T<sub>TOP</sub> is the temperature measured at the center-top of the device package.
- P<sub>D(MAX)</sub> is described at Equation 3 (7)

 $T_{J(MAX)} = T_{BOARD} + (\Psi_{JB} \times P_{D(MAX)})$ 

#### where

- T<sub>BOARD</sub> is the PCB surface temperature measured 1 mm from the device package and centered on the package edge.
- P<sub>D(MAX)</sub> is described at Equation 3

  (8)

For more information about the thermal characteristics  $\Psi_{JT}$  and  $\Psi_{JB}$ , see *Semiconductor and IC Package Thermal Metrics*; for more information about measuring  $T_{TOP}$  and  $T_{BOARD}$ , see *Using New Thermal Metrics*; and for more information about the EIA/JEDEC JESD51 PCB used for validating  $R_{\theta JA}$ , see the *TI Application Report Thermal Characteristics of Linear and Logic Packages Using JEDEC PCB Designs*. These application notes are available at www.ti.com.

#### 8.2.2.10 Recommended Continuous Operating Area

The continuous operational area of an LDO is limited by the input voltage  $(V_{IN})$ , the output voltage  $(V_{DO})$ , the output current  $(I_{OUT})$ , and the junction temperature  $(T_J)$ . The recommended area for continuous operation for a linear regulator can be separated into the following steps, and is shown in Figure 16.

- Limited by dropout: Dropout voltage limits the minimum differential voltage between the input and the output (V<sub>IN</sub> - V<sub>OUT</sub>) at a given output current level.
- Limited by the rated output current: The rated output current limits the maximum recommended output current level. Exceeding this rating causes the device to fall out of specification.
- Limited by thermals: This portion of the boundary is defined by Equation 6. The slope is nonlinear because
  the junction temperature of the LDO is controlled by the power dissipation (P<sub>D</sub>) across the LDO; therefore,
  when V<sub>IN</sub> V<sub>OUT</sub> increases, the output current must decrease in order to ensure that the rated maximum
  operating junction temperature of the device is not exceeded. Exceeding the maximum operating junction
  temperature rating can cause the device to fall out of specifications, reduces long-term reliability, and may
  activate the thermal shutdown protection circuitry.
- Limited by  $V_{IN}$  range: The rated operating input voltage range governs both the minimum and maximum of  $V_{IN} V_{OLIT}$ .



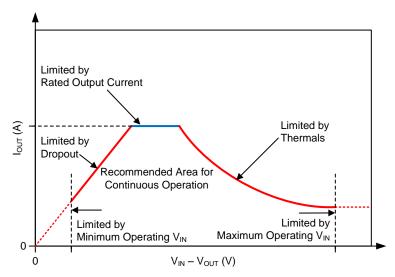
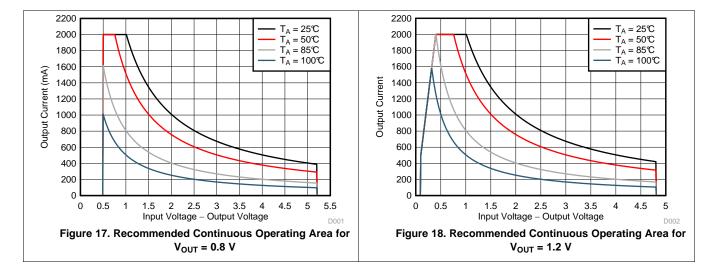
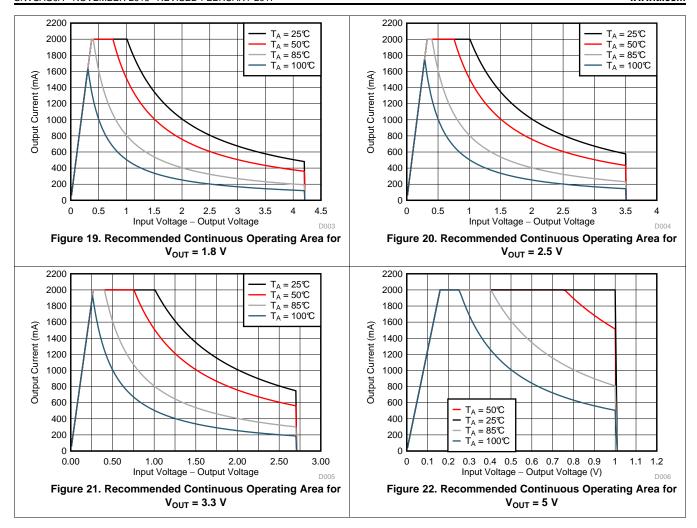


Figure 16. Recommended Continuous Operating Area

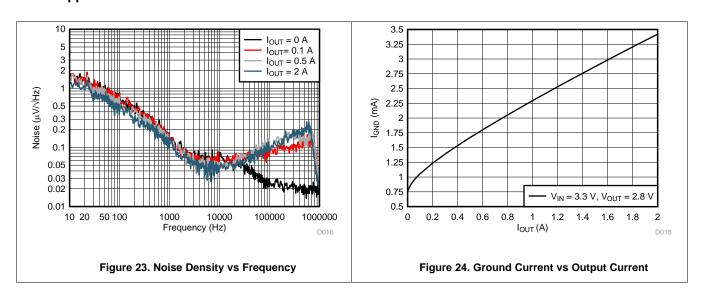
Figure 17 to Figure 22 show the recommended continuous operating area boundaries for this device in the WSON (DSC) package mounted to a EIA/JEDEC High-K printed circuit board, as defined by JESD51-7, with an  $R_{\theta JA}$  rating of 49.5°C/W.







# 8.2.3 Application Curves



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# 9 Power Supply Recommendations

This device is designed to operate from an input supply voltage range of 1.3 V to 6 V. The input supply should be well regulated and free of spurious noise. To ensure that the LP5922 output voltage is well regulated and dynamic performance is optimum, the input supply must be at least  $V_{OUT}$  + 1 V. A minimum capacitor value of 22  $\mu$ F is required to be within 1 cm of the IN pin.

# 10 Layout

# 10.1 Layout Guidelines

The dynamic performance of the LP5922 is dependant on the layout of the PCB. PCB layout practices that are adequate for typical LDOs may degrade the PSRR, noise, or transient performance of the LP5922.

Best performance is achieved by placing  $C_{\text{IN}}$  and  $C_{\text{OUT}}$  on the same side of the PCB as the LP5922 device, and as close as is practical to the package. The ground connections for  $C_{\text{IN}}$  and  $C_{\text{OUT}}$  must be back to the LP5922 GND pin using as wide and as short of a copper trace as is practical.

Avoid connections using long trace lengths, narrow trace widths, or connections through vias. These add parasitic inductances and resistance that results in inferior performance especially during transient conditions

## 10.2 Layout Example

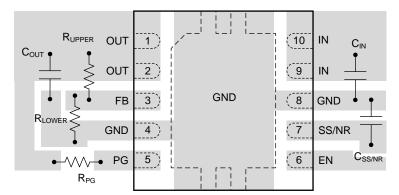


Figure 25. LP5922 Typical Layout

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# 11 Device and Documentation Support

# 11.1 Device Support

#### 11.1.1 Development Support

#### 11.1.1.1 Custom Design With WEBENCH® Tools

Click here to create a custom design using the LP5922 device with the WEBENCH® Power Designer.

- 1. Start by entering the input voltage (V<sub>IN</sub>), output voltage (V<sub>OUT</sub>), and output current (I<sub>OUT</sub>) requirements.
- 2. Optimize the design for key parameters such as efficiency, footprint, and cost using the optimizer dial.
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The WEBENCH Power Designer provides a customized schematic along with a list of materials with real-time pricing and component availability.

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- Run thermal simulations to understand board thermal performance.
- Export customized schematic and layout into popular CAD formats.
- Print PDF reports for the design, and share the design with colleagues.

Get more information about WEBENCH tools at www.ti.com/WEBENCH.

#### 11.2 Related Documentation

For additional information, see the following:

- Using New Thermal Metrics
- Thermal Characteristics of Linear and Logic Packages Using JEDEC PCB Designs

# 11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community T's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.5 Trademarks

E2E is a trademark of Texas Instruments.

WEBENCH is a registered trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.



# 11.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
LP592201DSCR	NRND	Production	WSON (DSC)   10	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	592201
LP592201DSCR.A	NRND	Production	WSON (DSC)   10	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	592201
LP592201DSCT	NRND	Production	WSON (DSC)   10	250   SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	592201
LP592201DSCT.A	NRND	Production	WSON (DSC)   10	250   SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	592201

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

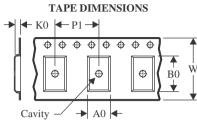
<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 3-Jun-2022

# TAPE AND REEL INFORMATION





	•
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

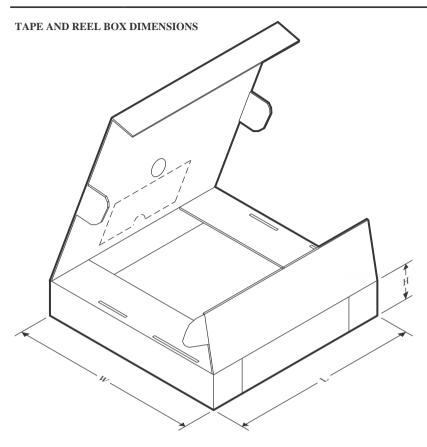


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LP592201DSCR	WSON	DSC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
LP592201DSCT	WSON	DSC	10	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

# **PACKAGE MATERIALS INFORMATION**

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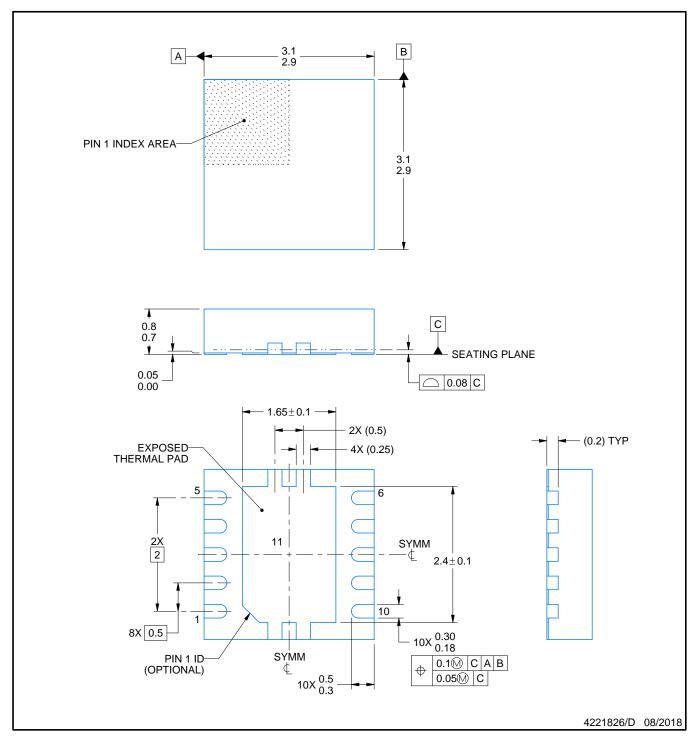


# \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LP592201DSCR	WSON	DSC	10	3000	367.0	367.0	35.0
LP592201DSCT	WSON	DSC	10	250	210.0	185.0	35.0



PLASTIC SMALL OUTLINE - NO LEAD

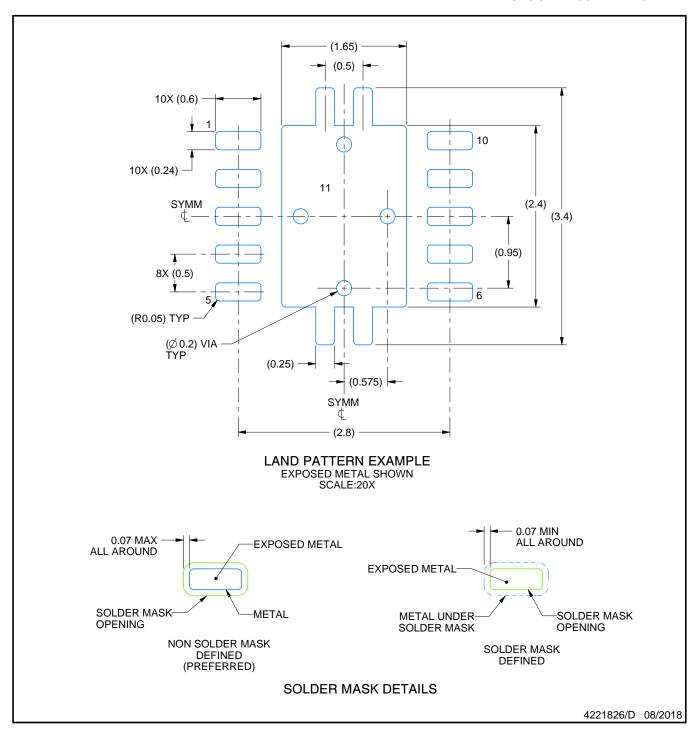


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



PLASTIC SMALL OUTLINE - NO LEAD

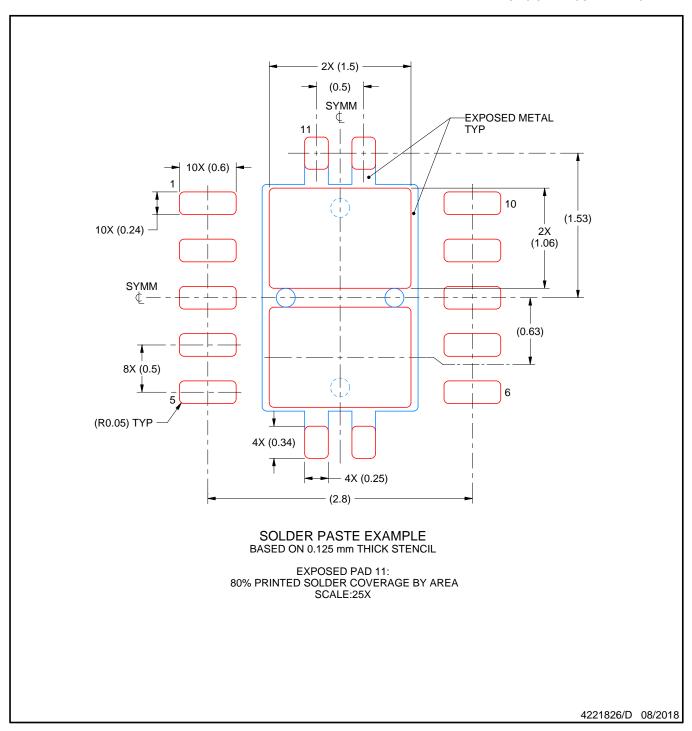


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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